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<td>Author(s)</td>
<td>Adachi, F.; Matsumoto, T.</td>
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<tr>
<td>Citation</td>
<td>Electronics Letters, 27(17): 1571-1573</td>
</tr>
<tr>
<td>Issue Date</td>
<td>1991-08-15</td>
</tr>
<tr>
<td>Type</td>
<td>Journal Article</td>
</tr>
<tr>
<td>Text version</td>
<td>publisher</td>
</tr>
<tr>
<td>URL</td>
<td><a href="http://hdl.handle.net/10119/4804">http://hdl.handle.net/10119/4804</a></td>
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**Description**

The proposed MDPSK system is analyzed to improve the error rate. The error rate of the proposed system is compared with the conventional MDPSK system. The results show that the proposed system has a lower error rate than the conventional system. The performance of the proposed system is also evaluated under various conditions, including signal-to-noise ratio and modulation index. The results indicate that the proposed system maintains a low error rate under all conditions. The proposed system is expected to be useful in practical applications where a low error rate is required.
current density of 1.81 kA cm⁻² for broad area lasers (50 μm × 300 μm) was obtained at 628 nm.

H. MURATA
Y. TERUI
M. SATOH
Y. SATOH
R. TERASAKI

Electronics Material Department
Research Center
Denki Kagaku Kogyo Co., Ltd.
5-3-1 Asasumachi
Machida-shi, Tokyo 194, Japan

DOUBLE SYMBOL ERROR RATE AND BLOCK ERROR RATE OF MDPSK

Introduction: Error control, such as forward error correction (FEC) and automatic repeat request (ARQ), is often used to improve bit error rate (BER) performance. In M-ary differential phase shift keying (MDPSK) systems, symbol errors tend to be produced in pairs due to differential detection. When the phase of the signal plus additive noise at decision time \( t = N T \) is represented by \( \theta_{n} \), the nth symbol is determined from \( \Delta \theta_{n} = \theta_{n} - \theta_{n-1} \) and the \( (n-1) \)-th symbol from \( \Delta \theta_{n-1} = \theta_{n-1} - \theta_{n-2} \). Therefore, if noise forces a large phase deviation in \( \theta_{n-1} \), two consecutive symbol errors (double symbol error) are likely to be produced. Statistics of symbol error patterns affect the FEC performance. In this Letter, the double symbol error rate (DSER) of an M-ary DPSK (MDPSK) system is calculated. When ARQ is used (no FEC is incorporated), retransmission is requested if the received data block contains at least one single error. This Letter also calculates the block error rate (BKER) taking into account the effect of double symbol error.

Calculation of DSER: Oberst and Shilling⁶ calculated the DSER for 2DPSK (or BDPSK). Goldberg⁵ extended the analysis to MDPSK (however, the calculated results were shown only for \( M = 2 \) and 4). We present a simple, approximate DSER calculation method and calculate the conditional SER which is defined as the SER when the previous symbol decision was in error.

The phase of detector input signal is fluctuated by additive noise. Let \( \phi \) be the phase error of \( \theta_{n-1} \) from the ideal phase point \( \Theta = \pm \pi M \), \( m = 0, 1, \ldots, M - 1 \), at decision time \( t = (n - 1)T \). The nth symbol and \( (n-1) \)-th symbol are correctly detected if the phase errors of \( \theta_{n-1} \) and \( \theta_{n-2} \) lie between \( \pm \frac{\pi}{M} \) and \( \pm \frac{\pi}{M} - \pi M \). Assuming that noise samples are independent Gaussian variables, SERs of the nth and \( (n-1) \)-th symbols, when the phase error of \( \theta_{n-1} \) is \( \phi \), can be given by

\[
\frac{P(E_{n|\phi})}{P(E_{n-1|\phi})} = \frac{1}{2} \text{erfc} \left( \frac{\sqrt{2}}{2} \frac{\phi}{\gamma} \right) + \frac{1}{2} \text{erf} \left( \frac{\sqrt{2}}{2} \frac{-\phi}{\gamma} \right)
\]

(1)

where \( \gamma \) is the signal-to-noise ratio. Eqn. 1 is an exact expression for 4DPSK (or QDPSK). For MDPSK with \( M \geq 8 \), however, it is an upper bound. Because the third term in the right-hand side of eqn. 1 is negligible for large values of \( \gamma \), eqn. 1 gives a good approximation. SER \( P(E_{n}) \) is obtained by averaging \( P(E_{n|\phi}) \) with the probability density function \( p(\phi) \):

\[
p(\phi) = \frac{1}{2\pi} e^{-\frac{\phi^2}{2}} \frac{1}{2} \frac{\phi}{\gamma} e^{-\frac{\phi^2}{2\gamma^2}}
\]

(2)

Because error events \( E_{n} \) and \( E_{n-1} \) are independent, DSER can be calculated from

\[
P(E_{n}, E_{n-1}) = \int_{-\infty}^{\infty} P(E_{n|\phi}) P(E_{n-1|\phi}) p(\phi) d\phi
\]

(3)

Finally, conditional SER \( P(E_{n}|E_{n-1}) \) can be obtained from

\[
P(E_{n}, E_{n-1}) = \int_{-\infty}^{\infty} p(E_{n}|\phi)p(E_{n-1}|\phi) p(\phi) d\phi
\]

Fig. 1 shows the calculated results of the conditional SER as a function of signal energy per bit-to-noise power spectrum density ratio \( E_{b}/N_{0} = \frac{2}{3}\log_{2} M \). For comparison, SER is also shown (it was found that SER performance when \( M \geq 8 \) is almost identical with the exact one calculated from Reference 4). It can be seen that the conditional SER of BDPSK decreases very slowly and is larger than that of QDPSK when \( E_{b}/N_{0} \gtrsim 4 \text{dB} \). The conditional SERs at various values of SER were obtained from Fig. 1 and compared in Fig. 2. At an SER of \( 10^{-4} \), the conditional SERs are \( 1.8 \times 10^{-4} \) for \( M = 2 \), \( 5.0 \times 10^{-4} \) for \( M = 4 \), \( 3.5 \times 10^{-4} \) for \( M = 8 \), and \( 3.4 \times 10^{-2} \) for \( M = 16 \). It can be seen that when compared at the same SER value, the conditional SER is largest for BDPSK and those for MDPSK with \( M \geq 4 \) are similar. The reason why
the conditional SER of BDPSK is larger than those of the other schemes can be qualitatively explained. Because of the larger decision phase margin \( \frac{k}{2} \) of BDPSK, the \((n-1)\)th symbol is erroneously detected when a large phase error of \( \theta_{n-1} \) occurs. However, it is rare for the phase error of \( \theta_{n-1} \) to have the same sign and be able to cancel the effect of the previous phase error. This produces double symbol error. As \( M \) increases, however, the decision phase margin decreases and smaller phase error of \( \theta_{n-1} \) causes an error in the \((n-1)\)th symbol. Therefore, it is more likely for the phase error of \( \theta_{n-1} \) to cancel the effect of phase error of \( \theta_{n-1} \), so that double errors tend to be reduced.

**Fig. 1** Conditional SER

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<th>MDPSK</th>
<th>conditional SER</th>
<th>SER</th>
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**Fig. 2** Comparison of conditional SERs at various SERs

- \[ \text{SER} = 10^{-3} \]
- \[ \text{SER} = 10^{-3} \]
- \[ \text{SER} = 10^{-4} \]

**Block error rate**: Here, BKER is defined as the probability of the data block containing at least one single error. An \( N \)-symbol block is assumed. Because nonadjacent symbol decisions are independent, BKER can be calculated from

\[
\text{BKER} = 1 - \left( 1 - P(C_j) \right)^N \tag{4}
\]

where \( C_j \) is the event of correction decision for the \( j \)th symbol.

**Fig. 3** BKER performance

- \[ \text{eqn. 5} \]
- \[ \text{independent error} \]
Block length \( N = 64 \) MDPSK

Eqn. 5 can be approximated as

\[
\text{BKER} \approx N \cdot P(E_o) \left[ 1 - P(E_i | E_o) \right] \tag{6}
\]

for a high \( E_b/N_0 \). If symbol errors are independent, then \( \text{BKER} = 1 - [1 - P(E_o)]^N \approx N \cdot P(E_o) \). Hence, the BKER with differential detection is smaller by a factor of 1 - \( P(E_i | E_o) \) than that experienced with independent symbol error. It is found from Fig. 1 that the BKER of BDPSK becomes 72% of that determined assuming independent symbol error when \( E_b/N_0 = 8 \text{ dB} \). For \( M \geq 4 \), however, because \( 1 - P(E_i | E_o) \) is very small, the effect of double symbol error is negligible. This is confirmed by Fig. 3 in which BKER performance is plotted assuming independent symbol error.

**Conclusion**: The conditional SER of MDPSK with \( M \geq 4 \) is much smaller than that of BDPSK when compared at the same SER value. The effect of double symbol errors on BKER is negligible and therefore BKER is well approximated by that determined assuming independent symbol error when \( M \geq 4 \).

F. ADACHI
T. MATSUMOTO
NTT Radio Communication Systems Laboratories
1-2558 Tuke
Yokosuka-shi, Kanagawa-ken 238, Japan

5th July 1991

References

NOVEL LEAKY-WAVE ANTENNA FOR MILLIMETRE WAVES BASED ON V-GROOVE GUIDE

Indexing terms: Antennas, Waveguides

A novel type of leaky-wave antenna for millimetre waves based on the V-groove guide is described. A complete transverse equivalent network is presented for analysis and design of this new leaky-wave antenna. Numerical results for the performance characteristics of the antenna are given.

Introduction: The groove guide is potentially attractive as a low-loss waveguide in millimetre wave and submillimetre wave bands. Recently this kind of waveguiding structure has attracted increasing attention because of its advantages such as low-loss nature, ease of fabrication, large structural dimensions and higher power handling capacity. A leaky-wave antenna constructed from the groove guide was described and investigated by Oliner and Lampariello. This leaky groove guide antenna overcomes two problems that leaky-wave antennas for millimetre wave ranges often face: lower waveguiding efficiency and more effective rejection of higher order modes. Based on the V-groove guide, we present a new type of leaky-wave antenna. An accurate analysis, based on a transverse equivalent network, is presented for the properties of this leaky structure that takes into account the mode conversion from the bound mode to the leaky mode. Using this analysis, numerical design values can be readily obtained. The antenna structure is therefore able to be easily understood and systematically designed.

Analysis: The cross-section of the new leaky-wave antenna is shown in Fig. 1. As in References 1-3, it is the added continuous strip of width d which introduces asymmetry into the basic V-groove guide and creates the leakage. The strip therefore gives rise to an additional transverse mode and couples that mode to the original transverse mode which by itself would be purely bound.

The transverse equivalent network for the cross-section of the structure shown in Fig. 1 is given in Fig. 2. This network is based on these two transverse modes, which propagate in the x direction and are coupled by the narrow asymmetrical strip. These coupled transverse modes then combine to produce a net TE longitudinal mode (in the y direction) with a complex propagation constant $\beta - j\alpha$. In the network, the $l = 1$ transmission lines represent the original mode with a half-sine wave variation in the $y$ direction in Fig. 1, and the $l = 0$ transmission lines represent the new mode which has no variation with $y$. In the central region, the tapered lines represent the V-groove, which can be analysed by a numerical integration technique. The detailed formulation of the analysis method for the tapered lines can be found in a recent paper.

Numerical results: We have obtained numerical values in graphical form of the variation of $\beta$ and $\alpha$ with each of these dimensional parameters, so that design optimisation can proceed in a systematic fashion. However, we present here, in Figs. 3a and b, respectively, only the curves of $\beta/k$ and $\alpha/k$ as a function of $fa$ (where $f$ is the frequency in GHz and $a$ is the width of the central region in cm). It can be seen that the performance of the new V-groove guide leaky-wave antenna is very similar to that of the leaky rectangular-groove guide antenna. Because the cutoff wavelength of the V-groove guide is bigger than that of the rectangular-groove guide with the